ANALOG DEVICES

## Data Sheet

## FEATURES

Small package: 10-lead MSOP
Programmable gains: 1, 2, 5, 10
Digital or pin-programmable gain setting
Wide supply: $\pm 5 \mathrm{~V}$ to $\pm 15 \mathrm{~V}$
Excellent dc performance
High CMRR 98 dB (minimum), G = 10
Low gain drift: $10 \mathrm{ppm} /{ }^{\circ} \mathrm{C}$ (maximum)
Low offset drift: $1.7 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C}$ (maximum), $\mathbf{G}=10$
Excellent ac performance
Fast settling time: 615 ns to $\mathbf{0 . 0 0 1 \%}$ (maximum)
High slew rate: $20 \mathrm{~V} / \mu \mathrm{s}$ (minimum)
Low distortion: - $\mathbf{1 1 0} \mathbf{d B}$ THD at $\mathbf{1 k H z}$
High CMRR over frequency: 80 dB to $\mathbf{5 0} \mathbf{~ k H z}$ (minimum)
Low noise: $\mathbf{1 8 \mathrm { nV } / \sqrt { } \mathrm { Hz } , \mathrm { G } = 1 0 \text { (maximum) } ) ~}$
Low power: 4.1 mA

## APPLICATIONS

## Data acquisition

Biomedical analysis
Test and measurement

## GENERAL DESCRIPTION

The AD8250 is an instrumentation amplifier with digitally programmable gains that has $\mathrm{G} \Omega$ input impedance, low output noise, and low distortion making it suitable for interfacing with sensors and driving high sample rate analog-to-digital converters (ADCs). It has a high bandwidth of 10 MHz , low THD of -110 dB and fast settling time of 615 ns (maximum) to $0.001 \%$. Offset drift and gain drift are guaranteed to $1.7 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C}$ and $10 \mathrm{ppm} /{ }^{\circ} \mathrm{C}$, respectively, for $\mathrm{G}=10$. In addition to its wide input common voltage range, it boasts a high common-mode rejection of 80 dB at $G=1$ from dc to 50 kHz . The combination of precision dc performance coupled with high speed capabilities makes the AD8250 an excellent candidate for data acquisition. Furthermore, this monolithic solution simplifies design and manufacturing and boosts performance of instrumentation by maintaining a tight match of internal resistors and amplifiers.

The AD8250 user interface consists of a parallel port that allows users to set the gain in one of two ways (see Figure 1). A 2-bit word sent via a bus can be latched using the $\overline{\mathrm{WR}}$ input. An alternative is to use the transparent gain mode where the state of the logic levels at the gain port determines the gain.


Table 1. Instrumentation Amplifiers by Category

| General <br> Purpose | Zero Drift | Mil <br> Grade | Low <br> Power | High Speed <br> PGA |
| :--- | :--- | :--- | :--- | :--- |
| AD8220 $^{1}$ | AD8231 $^{1}$ | AD620 | AD627 $^{1}$ | AD8250 |
| AD8221 $^{\text {AD8222 }}$ | AD8553 $^{1}$ | AD621 | AD623 $^{1}$ | AD8251 |
| AD8224 | AD85561 $^{1}$ | AD524 | AD8223 $^{1}$ | AD8253 |
| AD8228 | AD8557 $^{1}$ | AD624 |  |  |

${ }^{1}$ Rail-to-rail output.
The AD8250 is available in a 10 -lead MSOP package and is specified over the $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ temperature range, making it an excellent solution for applications where size and packing density are important considerations.

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## SPECIFICATIONS

$+\mathrm{V}_{\mathrm{S}}=15 \mathrm{~V},-\mathrm{V}_{\mathrm{S}}=-15 \mathrm{~V}, \mathrm{~V}_{\mathrm{REF}}=0 \mathrm{~V} @ \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{G}=1, \mathrm{R}_{\mathrm{L}}=2 \mathrm{k} \Omega$, unless otherwise noted.
Table 2.

| Parameter | Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| COMMON-MODE REJECTION RATIO (CMRR) CMRR to 60 Hz with $1 \mathrm{k} \Omega$ Source Imbalance $\begin{aligned} \mathrm{G} & =1 \\ \mathrm{G} & =2 \\ \mathrm{G} & =5 \\ \mathrm{G} & =10 \end{aligned}$ <br> CMRR to 50 kHz $\begin{aligned} & \mathrm{G}=1 \\ & \mathrm{G}=2 \\ & \mathrm{G}=5 \\ & \mathrm{G}=10 \end{aligned}$ | $+\mathrm{IN}=-\mathrm{IN}=-10 \mathrm{~V} \text { to }+10 \mathrm{~V}$ $+\mathrm{IN}=-\mathrm{IN}=-10 \mathrm{~V} \text { to }+10 \mathrm{~V}$ | $\begin{aligned} & 80 \\ & 86 \\ & 94 \end{aligned}$ | $\begin{aligned} & 98 \\ & 104 \\ & 110 \\ & 110 \end{aligned}$ |  | dB <br> dB <br> dB <br> dB <br> dB <br> dB <br> dB <br> dB |
| NOISE <br> Voltage Noise, 1 kHz, RT। $\begin{aligned} \mathrm{G} & =1 \\ \mathrm{G} & =2 \\ \mathrm{G} & =5 \\ \mathrm{G} & =10 \end{aligned}$ <br> 0.1 Hz to 10 Hz , RTI $G=1$ <br> $\mathrm{G}=2$ <br> $\mathrm{G}=5$ $G=10$ <br> Current Noise, 1 kHz <br> Current Noise, 0.1 Hz to 10 Hz |  |  | $\begin{aligned} & 5 \\ & 60 \end{aligned}$ | $\begin{aligned} & 40 \\ & 27 \\ & 21 \\ & 18 \\ & 2.5 \\ & 2.5 \\ & 1.5 \\ & 1.0 \end{aligned}$ | $\mathrm{nV} / \sqrt{ } \mathrm{Hz}$ <br> $\mathrm{nV} / \sqrt{ } \mathrm{Hz}$ <br> $\mathrm{nV} / \sqrt{ } \mathrm{Hz}$ <br> $\mathrm{nV} / \sqrt{ } \mathrm{Hz}$ <br> $\mu \mathrm{V}$ p-p <br> $\mu \mathrm{V}$ p-p <br> $\mu \mathrm{V}$ p-p <br> $\mu \mathrm{V}$ p-p <br> $\mathrm{pA} / \sqrt{ } \mathrm{Hz}$ <br> pA p-p |
| VOLTAGE OFFSET <br> Offset RTI Vos <br> Over Temperature <br> Average Temperature Coefficient <br> Offset Referred to the Input vs. Supply (PSR) | $\begin{aligned} & \mathrm{G}=1,2,5,10 \\ & \mathrm{~T}=-40^{\circ} \mathrm{C} \text { to }+85^{\circ} \mathrm{C} \\ & \mathrm{~T}=-40^{\circ} \mathrm{C} \text { to }+85^{\circ} \mathrm{C} \\ & \mathrm{~V}_{\mathrm{s}}= \pm 5 \mathrm{~V} \text { to } \pm 15 \mathrm{~V} \end{aligned}$ |  | $\begin{aligned} & \pm(70+200 / \mathrm{G}) \\ & \pm(90+300 / \mathrm{G}) \\ & \pm(0.6+1.5 / \mathrm{G}) \\ & \pm(2+7 / \mathrm{G}) \end{aligned}$ | $\begin{aligned} & \pm(200+600 / \mathrm{G}) \\ & \pm(260+900 / \mathrm{G}) \\ & \pm(1.2+5 / \mathrm{G}) \\ & \pm(6+20 / \mathrm{G}) \end{aligned}$ | $\mu \mathrm{V}$ <br> $\mu \mathrm{V}$ <br> $\mu \mathrm{V} /{ }^{\circ} \mathrm{C}$ <br> $\mu \mathrm{V} / \mathrm{V}$ |
| INPUT CURRENT <br> Input Bias Current <br> Over Temperature <br> Average Temperature Coefficient <br> Input Offset Current <br> Over Temperature <br> Average Temperature Coefficient | $\begin{aligned} & \mathrm{T}=-40^{\circ} \mathrm{C} \text { to }+85^{\circ} \mathrm{C} \\ & \mathrm{~T}=-40^{\circ} \mathrm{C} \text { to }+85^{\circ} \mathrm{C} \\ & \mathrm{~T}=-40^{\circ} \mathrm{C} \text { to }+85^{\circ} \mathrm{C} \\ & \mathrm{~T}=-40^{\circ} \mathrm{C} \text { to }+85^{\circ} \mathrm{C} \end{aligned}$ |  |  | $\begin{aligned} & 30 \\ & 40 \\ & 400 \\ & 30 \\ & 30 \\ & 160 \end{aligned}$ | nA <br> nA <br> $\mathrm{pA} /{ }^{\circ} \mathrm{C}$ <br> nA <br> nA <br> $\mathrm{pA} /{ }^{\circ} \mathrm{C}$ |
| DYNAMIC RESPONSE <br> Small Signal -3 dB Bandwidth $\begin{aligned} \mathrm{G} & =1 \\ \mathrm{G} & =2 \\ \mathrm{G} & =5 \\ \mathrm{G} & =10 \end{aligned}$ <br> Settling Time 0.01\% $\begin{aligned} \mathrm{G} & =1 \\ \mathrm{G} & =2 \\ \mathrm{G} & =5 \\ \mathrm{G} & =10 \end{aligned}$ | $\Delta \mathrm{OUT}=10 \mathrm{~V}$ step | $\begin{aligned} & 10 \\ & 10 \\ & 10 \\ & 3 \end{aligned}$ |  | $\begin{aligned} & 585 \\ & 605 \\ & 605 \\ & 648 \end{aligned}$ | MHz <br> MHz <br> MHz <br> MHz <br> ns <br> ns <br> ns <br> ns |



## Data Sheet

| Parameter | Conditions | Min | Typ | Max |  |
| :--- | :--- | :--- | :--- | :--- | :--- |
| POWER SUPPLY |  |  |  |  |  |
| Operating Range |  | $\pm 5$ |  | $\pm 15$ |  |
| Quiescent Current, $+I_{s}$ |  |  | 4.1 | 4.5 | V |
| Quiescent Current, $-\mathrm{I}_{\mathrm{s}}$ | $\mathrm{T}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  | 3.7 | 4.5 | mA |
| Over Temperature |  | -40 | 4.5 | mA |  |
| TEMPERATURE RANGE |  |  | +85 |  |  |
| Specified Performance |  |  | ${ }^{\circ} \mathrm{C}$ |  |  |

${ }^{1}$ Add time for the output to slew and settle to calculate the total time for a gain change.

## TIMING DIAGRAM



Figure 3. Timing Diagram for Latched Gain Mode (See the Timing for Latched Gain Mode Section)

## ABSOLUTE MAXIMUM RATINGS

Table 3.

| Parameter |
| :--- |
| Supply Voltage |
| Power Dissipation |
| Output Short-Circuit Current |
| Common-Mode Input Voltage |
| Differential Input Voltage |
| Digital Logic Inputs |
| Storage Temperature Range |
| Operating Temperature Range |
| Lead Temperature (Soldering, 10 sec) |
| Junction Temperature |
| Өja (Four-Layer JEDEC Standard Board) |
| Package Glass Transition Temperature |

The power dissipated in the package $\left(\mathrm{P}_{\mathrm{D}}\right)$ is the sum of the quiescent power dissipation and the power dissipated in the package due to the load drive for all outputs. The quiescent power is the voltage between the supply pins $\left(\mathrm{V}_{\mathrm{S}}\right)$ times the quiescent current $\left(\mathrm{I}_{\mathrm{S}}\right)$. Assuming that the load $\left(\mathrm{R}_{\mathrm{L}}\right)$ is referenced to midsupply, the total drive power is $\mathrm{V}_{\mathrm{S}} / 2 \times$ Iout, some of which is dissipated in the package and some in the load (Vout $\times$ Iout).

The difference between the total drive power and the load power is the drive power dissipated in the package.

$$
\begin{aligned}
& P_{D}=\text { Quiescent Power }+(\text { Total Drive Power }- \text { Load Power }) \\
& P_{D}=\left(V_{S} \times I_{S}\right)+\left(\frac{V_{S}}{2} \times \frac{V_{\text {OUT }}}{R_{L}}\right)-\frac{V_{\text {OUT }}{ }^{2}}{R_{L}}
\end{aligned}
$$

In single-supply operation with $\mathrm{R}_{\mathrm{L}}$ referenced to $-\mathrm{V}_{\mathrm{s}}$, the worst case is $V_{\text {out }}=\mathrm{V}_{\mathrm{s}} / 2$.

Airflow increases heat dissipation, effectively reducing $\theta_{\mathrm{JA}}$. In addition, more metal directly in contact with the package leads from metal traces, through holes, ground, and power planes reduces the $\theta_{\text {IA }}$.

Figure 4 shows the maximum safe power dissipation in the package vs. the ambient temperature on a four-layer JEDEC standard board.


Figure 4. Maximum Power Dissipation vs. Ambient Temperature

## ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



Table 4. Pin Function Descriptions

| Pin No. | Mnemonic | Description |
| :--- | :--- | :--- |
| 1 | - IN | Inverting Input Terminal. True differential input. |
| 2 | DGND | Digital Ground. |
| 3 | $-V_{s}$ | Negative Supply Terminal. |
| 4 | AO | Gain Setting Pin (LSB). |
| 5 | A1 | Gain Setting Pin (MSB). |
| 6 | WR | Write Enable. |
| 7 | OUT | Output Terminal. |
| 8 | $+V_{s}$ | Positive Supply Terminal. |
| 9 | REF | Reference Voltage Terminal. |
| 10 | + IN | Noninverting Input Terminal. True differential input. |

## TYPICAL PERFORMANCE CHARACTERISTICS

$\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C},+\mathrm{V}_{\mathrm{S}}=+15 \mathrm{~V},-\mathrm{V}_{\mathrm{S}}=-15 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=10 \mathrm{k} \Omega$, unless otherwise noted.


Figure 6. Typical Distribution of CMRR, $G=1$


Figure 7. Typical Distribution of Offset Voltage, Vosı


Figure 8. Typical Distribution of Input Bias Current


Figure 9. Typical Distribution of Input Offset Current


Figure 10. Voltage Spectral Density Noise vs. Frequency


Figure 11. 0.1 Hz to 10 Hz RTI Voltage Noise, $\mathrm{G}=1$


Figure 12. 0.1 Hz to 10 Hz RTI Voltage Noise, $G=10$


Figure 13. Current Noise Spectral Density vs. Frequency


Figure 14.0.1 Hz to 10 Hz Current Noise


Figure 15. Positive PSRR vs. Frequency, RTI


Figure 16. Negative PSRR vs. Frequency, RTI


Figure 17. Change in Offset Voltage, RTI vs. Warmup Time


Figure 18. Input Bias Current and Offset Current vs. Temperature


Figure 19. CMRR vs. Frequency


Figure 20. CMRR vs. Frequency, $1 \mathrm{k} \Omega$ Source Imbalance


Figure 21. CMRR vs. Temperature, $G=1$


Figure 22. Gain vs. Frequency


Figure 23. Gain Nonlinearity vs. Output Voltage, $G=1, R_{L}=10 \mathrm{k} \Omega, 2 \mathrm{k} \Omega, 600 \Omega$


Figure 24. Gain Nonlinearity vs. Output Voltage, $G=2, R_{L}=10 k \Omega, 2 k \Omega, 600 \Omega$


Figure 25. Gain Nonlinearity vs. Output Voltage, $G=5, R_{L}=10 \mathrm{k} \Omega, 2 \mathrm{k} \Omega, 600 \Omega$


Figure 26. Gain Nonlinearity vs. Output Voltage, $G=10, R_{L}=10 k \Omega, 2 k \Omega, 600 \Omega$


Figure 27. Input Common-Mode Voltage Range vs. Output Voltage, $G=1$


Figure 28. Input Common-Mode Voltage Range vs. Output Voltage, $G=10$


Figure 29. Input Bias Current and Offset Current vs. Common-Mode Voltage


Figure 30. Input Voltage Limit vs. Supply Voltage, $G=1, V_{R E F}=0 \mathrm{~V}, R_{L}=10 \mathrm{k} \Omega$


Figure 31. Fault Current Draw vs. Input Voltage, $G=10, R_{L}=10 \mathrm{k} \Omega$


Figure 32. Output Voltage Swing vs. Supply Voltage, $G=10, R_{L}=2 \mathrm{k} \Omega$


Figure 33. Output Voltage Swing vs. Supply Voltage, $G=10, R_{L}=10 \mathrm{k} \Omega$


Figure 34. Output Voltage Swing vs. Load Resistance


Figure 35. Output Voltage Swing vs. Output Current


Figure 36. Small Signal Pulse Response for Various Capacitive Loads


Figure 37. Large Signal Pulse Response and Settling Time, $G=1, R_{L}=10 \mathrm{k} \Omega$


Figure 38. Large Signal Pulse Response and Settling Time $G=2, R_{L}=10 \mathrm{k} \Omega$


Figure 39. Large Signal Pulse Response and Settling Time $G=5, R_{L}=10 \mathrm{k} \Omega$


Figure 40. Large Signal Pulse Response and Settling Time $G=10, R_{L}=10 \mathrm{k} \Omega$


Figure 41. Small Signal Response $G=1, R_{L}=2 \mathrm{k} \Omega, C_{L}=100 \mathrm{pF}$


Figure 42. Small Signal Response
$G=2, R_{L}=2 \mathrm{k} \Omega, C_{L}=100 \mathrm{pF}$


Figure 43. Small Signal Response
$G=5, R_{L}=2 \mathrm{k} \Omega, C_{L}=100 \mathrm{pF}$


Figure 44. Small Signal Response, $G=10, R_{L}=2 \mathrm{k} \Omega, C_{L}=100 \mathrm{pF}$


Figure 45. Total Harmonic Distortion + Noise vs. Frequency, 10 Hz to 22 kHz Band-Pass Filter, $R_{L}=2 \mathrm{k} \Omega$


Figure 46. Total Harmonic Distortion + Noise vs. Frequency, 10 Hz to 500 kHz Band-Pass Filter, $R_{L}=2 \mathrm{k} \Omega$

## THEORY OF OPERATION



Figure 47. Simplified Schematic

The AD8250 is a monolithic instrumentation amplifier based on the classic, 3-op-amp topology as shown in Figure 47. It is fabricated on the Analog Devices, Inc., proprietary $i \mathrm{CMOS}^{\bullet}$ process that provides precision, linear performance, and a robust digital interface. A parallel interface allows users to digitally program gains of $1,2,5$, and 10 . Gain control is achieved by switching resistors in an internal, precision resistor array (as shown in Figure 47). Although the AD8250 has a voltage feedback topology, the gain bandwidth product increases for gains of 1,2, and 5 because each gain has its own frequency compensation. This results in maximum bandwidth at higher gains.

All internal amplifiers employ distortion cancellation circuitry and achieve high linearity and ultralow THD. Laser trimmed resistors allow for a maximum gain error of less than $0.03 \%$ for $\mathrm{G}=1$ and minimum CMRR of 98 dB for $\mathrm{G}=10$. A pinout optimized for high CMRR over frequency enables the AD8250 to offer a guaranteed minimum CMRR over frequency of 80 dB at $50 \mathrm{kHz}(\mathrm{G}=1)$. The balanced input reduces the parasitics that, in the past, adversely affected CMRR performance.

## GAIN SELECTION

Logic low and logic high voltage limits are listed in the Specifications section. Typically, logic low is 0 V and logic high is 5 V ; both voltages are measured with respect to DGND. See Table 2 for the permissible voltage range of DGND. The gain of the AD8250 can be set using two methods.

## Transparent Gain Mode

The easiest way to set the gain is to program it directly via a logic high or logic low voltage applied to A 0 and A1. Figure 48 shows an example of this gain setting method, referred to throughout the data sheet as transparent gain mode. Tie $\overline{\mathrm{WR}}$ to the negative supply to engage transparent gain mode. In this mode, any change in voltage applied to A0 and A1 from logic low to logic high, or vice versa, immediately results in a gain change. Table 5 is the truth table for transparent gain mode, and Figure 48 shows the AD8250 configured in transparent gain mode.


NOTE:

1. IN TRANSPARENT GAIN MODE, $\overline{W R}$ IS TIED TO - $V_{S}$. THE VOLTAGE LEVELS ON A0 AND A1 DETERMINE THE GAIN. IN THIS EXAMPLE, BOTH A0 AND A1 ARE
SET TO LOGIC HIGH, RESULTING IN A GAIN OF 10.

Figure 48. Transparent Gain Mode, A0 and A1 $=$ High, $G=10$

## AD8250

Table 5. Truth Table Logic Levels for Transparent Gain Mode

| $\overline{\mathbf{W R}}$ | A1 | A0 | Gain |
| :--- | :--- | :--- | :--- |
| $-V_{s}$ | Low | Low | 1 |
| $-V_{s}$ | Low | High | 2 |
| $-V_{s}$ | High | Low | 5 |
| $-V_{s}$ | High | High | 10 |

## Latched Gain Mode

Some applications have multiple programmable devices such as multiplexers or other programmable gain instrumentation amplifiers on the same PCB. In such cases, devices can share a data bus. The gain of the AD8250 can be set using $\overline{\mathrm{WR}}$ as a latch, allowing other devices to share A0 and A1. Figure 49 shows a schematic using this method, known as latched gain mode. The AD8250 is in this mode when $\overline{W R}$ is held at logic high or logic low, typically 5 V and 0 V , respectively. The voltages on A0 and A 1 are read on the downward edge of the $\overline{\mathrm{WR}}$ signal as it transitions from logic high to logic low. This latches in the logic levels on A0 and A1, resulting in a gain change. See the truth table in Table 6 for more information on these gain changes.


Figure 49. Latched Gain Mode, $G=10$

Table 6. Truth Table Logic Levels for Latched Gain Mode

| $\overline{\mathbf{W R}}$ | A1 | A0 | Gain |
| :--- | :--- | :--- | :--- |
| High to low | Low | Low | Change to 1 |
| High to low | Low | High | Change to 2 |
| High to low | High | Low | Change to 5 |
| High to low | High | High | Change to 10 |
| Low to low | $\mathrm{X}^{1}$ | $\mathrm{X}^{1}$ | No change |
| Low to high | $\mathrm{X}^{1}$ | $\mathrm{X}^{1}$ | No change |
| High to high | $\mathrm{X}^{1}$ | $\mathrm{X}^{1}$ | No change |

${ }^{1} \mathrm{X}=$ don't care.
On power-up, the AD8250 defaults to a gain of 1 when in latched gain mode. In contrast, if the AD8250 is configured in transparent gain mode, it starts at the gain indicated by the voltage levels on A0 and A1 at power-up.

## Timing for Latched Gain Mode

In latched gain mode, logic levels at A0 and A1 have to be held for a minimum setup time, $t_{s u}$, before the downward edge of $\overline{\mathrm{WR}}$ latches in the gain. Similarly, they must be held for a minimum hold time of $t_{H D}$ after the downward edge of $\overline{\mathrm{WR}}$ to ensure that the gain is latched in correctly. After $\mathrm{t}_{\mathrm{HD}}, \mathrm{A} 0$ and A 1 can change logic levels, but the gain does not change (until the next downward edge of $\overline{\mathrm{WR}}$ ). The minimum duration that $\overline{\mathrm{WR}}$ can be held high is $\mathrm{t} \overline{\mathrm{wr}-\mathrm{HIGH}}$, and the minimum duration that $\overline{\mathrm{WR}}$ can be held low is $\mathrm{t} \overline{\mathrm{WR}}$-Low. Digital timing specifications are listed in Table 2. The time required for a gain change is dominated by the settling time of the amplifier. A timing diagram is shown in Figure 50.

When sharing a data bus with other devices, logic levels applied to those devices can potentially feed through to the output of the AD8250. Feedthrough can be minimized by decreasing the edge rate of the logic signals. Furthermore, careful layout of the PCB also reduces coupling between the digital and analog portions of the board. Pull-up or pull-down resistors should be used to provide a well-defined voltage at the A 0 and A 1 pins.


Figure 50. Timing Diagram for Latched Gain Mode

## POWER SUPPLY REGULATION AND BYPASSING

The AD8250 has high PSRR. However, for optimal performance, a stable dc voltage should be used to power the instrumentation amplifier. Noise on the supply pins can adversely affect performance. As in all linear circuits, bypass capacitors must be used to decouple the amplifier.

Place a $0.1 \mu \mathrm{~F}$ capacitor close to each supply pin. A $10 \mu \mathrm{~F}$ tantalum capacitor can be used farther away from the part (see Figure 51) and, in most cases, it can be shared by other precision integrated circuits.


Figure 51. Supply Decoupling, REF, and Output Referred to Ground

## INPUT BIAS CURRENT RETURN PATH

The AD8250 input bias current must have a return path to its local analog ground. When the source, such as a thermocouple, cannot provide a return current path, one should be created (see Figure 52).


Figure 52. Creating an $I_{B I A S}$ Return Path

## INPUT PROTECTION

All terminals of the AD8250 are protected against ESD. Note that $2.2 \mathrm{k} \Omega$ series resistors precede the ESD diodes as shown in Figure 47. The resistors limit current into the diodes and allow for dc overload conditions 13 V above the positive supply and 13 V below the negative supply. An external resistor should be used in series with each input to limit current for voltages greater than 13 V beyond either supply rail. In either scenario, the AD8250 safely handles a continuous 6 mA current at room temperature. For applications where the AD8250 encounters extreme overload voltages, external series resistors and low leakage diode clamps, such as BAV199Ls, FJH1100s, or SP720s, should be used.

## REFERENCE TERMINAL

The reference terminal, REF, is at one end of a $10 \mathrm{k} \Omega$ resistor (see Figure 47). The instrumentation amplifier output is referenced to the voltage on the REF terminal; this is useful when the output signal needs to be offset to voltages other than its local analog ground. For example, a voltage source can be tied to the REF pin to level shift the output so that the AD8250 can interface with a single-supply ADC. The allowable reference voltage range is a function of the gain, common-mode input, and supply voltages. The REF pin should not exceed either $+V_{s}$ or $-\mathrm{V}_{\mathrm{S}}$ by more than 0.5 V .

For best performance, especially in cases where the output is not measured with respect to the REF terminal, source impedance to the REF terminal should be kept low because parasitic resistance can adversely affect CMRR and gain accuracy.


## COMMON-MODE INPUT VOLTAGE RANGE

The 3-op-amp architecture of the AD8250 applies gain and then removes the common-mode voltage. Therefore, internal nodes in the AD8250 experience a combination of both the gained signal and the common-mode signal. This combined signal can be limited by the voltage supplies even when the individual input and output signals are not. Figure 27 and Figure 28 show the allowable common-mode input voltage ranges for various output voltages, supply voltages, and gains.

## LAYOUT

## Grounding

In mixed-signal circuits, low level analog signals need to be isolated from the noisy digital environment. Designing with the AD8250 is no exception. Its supply voltages are referenced to an analog ground. Its digital circuit is referenced to a digital ground. Although it is convenient to tie both grounds to a single ground plane, the current traveling through the ground wires and PCB can cause errors. Therefore, use separate analog and digital ground planes. Analog and digital ground should meet at only one point: star ground.

The output voltage of the AD8250 develops with respect to the potential on the reference terminal. Take care to tie REF to the appropriate local analog ground or to connect it to a voltage that is referenced to the local analog ground.

## Coupling Noise

To prevent coupling noise onto the AD8250, do the following guidelines:

- Do not run digital lines under the device.
- Run the analog ground plane under the AD8250.
- Shield fast switching signals with digital ground to avoid radiating noise to other sections of the board, and never run them near analog signal paths.
- Avoid crossover of digital and analog signals.
- Connect digital and analog ground at one point only (typically under the ADC).
- Use the large traces on power supply lines to ensure a low impedance path. Decoupling is necessary; follow the guidelines listed in the Power Supply Regulation and Bypassing section.


## Common-Mode Rejection

The AD8250 has high CMRR over frequency, giving it greater immunity to disturbances, such as line noise and its associated harmonics, in contrast to typical instrumentation amplifiers whose CMRR falls off around 200 Hz . Typical instrumentation amplifiers often need common-mode filters at their inputs to compensate for this shortcoming. The AD8250 is able to reject CMRR over a greater frequency range, reducing the need for input common-mode filtering.

Careful board layout maximizes system performance. To maintain high CMRR over frequency, lay out the input traces symmetrically. Ensure that the traces maintain resistive and capacitive balance; this holds for additional PCB metal layers under the input pins and traces. Source resistance and capacitance should be placed as close to the inputs as possible. Should a trace cross the inputs (from another layer), route it perpendicular to the input traces.

## RF INTERFERENCE

RF rectification is often a problem when amplifiers are used in applications where there are strong RF signals. The disturbance can appear as a small dc offset voltage. High frequency signals can be filtered with a low-pass RC network placed at the input of the instrumentation amplifier, as shown in Figure 54. The filter limits the input signal bandwidth according to the following relationship:

$$
\begin{aligned}
& \text { FilterFreq }_{\text {DIFF }}=\frac{1}{2 \pi R\left(2 C_{D}+C_{C}\right)} \\
& \text { FilterFreq }_{C M}=\frac{1}{2 \pi R C_{C}}
\end{aligned}
$$

where $C_{D} \geq 10 \mathrm{Cc}$.


Figure 54. RFI Suppression
Values of R and Cc should be chosen to minimize RFI. A mismatch between the $\mathrm{R} \times \mathrm{C}_{\mathrm{C}}$ at the positive input and the $\mathrm{R} \times \mathrm{C}_{\mathrm{C}}$ at the negative input degrades the CMRR of the AD8250. By using a value of $C_{D}$ that is 10 times larger than the value of $\mathrm{C}_{\mathrm{C}}$, the effect of the mismatch is reduced and performance is improved.

## DRIVING AN ADC

An instrumentation amplifier is often used in front of an ADC to provide CMRR. Usually, instrumentation amplifiers require a buffer to drive an ADC. However, the low output noise, low distortion, and low settle time of the AD8250 make it an excellent ADC driver.

In this example, a 1 nF capacitor and a $100 \Omega$ resistor create an antialiasing filter for the AD7612. The 1 nF capacitor stores and delivers the necessary charge to the switched capacitor input of the ADC. The $100 \Omega$ series resistor reduces the burden of the 1 nF load from the amplifier and isolates it from the kickback current injected from the switched capacitor input of the AD7612. Selecting too small a resistor improves the correlation between the voltage at the output of the AD8250 and the voltage at the input of the AD7612 but may destabilize the AD8250. A tradeoff must be made between selecting a resistor small enough to maintain accuracy and large enough to maintain stability.


Figure 55. Driving an ADC

## APPLICATIONS

## DIFFERENTIAL OUTPUT

In certain applications, it is necessary to create a differential signal. High resolution ADCs often require a differential input. In other cases, transmission over a long distance can require differential signals for better immunity to interference.

Figure 57 shows how to configure the AD8250 to output a differential signal. An op amp, the AD817, is used in an inverting topology to create a differential voltage. $\mathrm{V}_{\text {REF }}$ sets the output midpoint according to the equation shown in the figure. Errors from the op amp are common to both outputs and are thus common mode. Likewise, errors from using mismatched resistors cause a common-mode dc offset error. Such errors are rejected in differential signal processing by differential input ADCs or instrumentation amplifiers.

## SETTING GAINS WITH A MICROCONTROLLER



Figure 56. Programming Gain Using a Microcontroller
When using this circuit to drive a differential ADC, $\mathrm{V}_{\text {Ref }}$ can be set using a resistor divider from the ADC reference to make the output ratiometric with the ADC.


Figure 57. Differential Output with Level Shift

## DATA ACQUISITION

The AD8250 makes an excellent instrumentation amplifier for use in data acquisition systems. Its wide bandwidth, low distortion, low settling time, and low noise enable it to condition signals in front of a variety of 16-bit ADCs.

Figure 59 shows a schematic of the AD825x data acquisition demonstration board. The quick slew rate of the AD8250 allows it to condition rapidly changing signals from the multiplexed inputs. An FPGA controls the AD7612, AD8250, and ADG1209. In addition, mechanical switches and jumpers allow users to pin strap the gains when in transparent gain mode.

This system achieved -111 dB of THD at 1 kHz and a signal-tonoise ratio of 91 dB during testing, as shown in Figure 58.


Figure 58. FFT of the AD825x DAQ Demo Board Using the AD8250, 1 kHz Signal


Figure 59. Schematic of ADG1209, AD8250, and AD7612 in the AD825x DAQ Demo Board

## OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-187-BA
Figure 60. 10-Lead Mini Small Outline Package [MSOP] (RM-10)
Dimensions shown in millimeters

## ORDERING GUIDE

| Model $^{1}$ | Temperature Range | Package Description | Package Option | Branding |
| :--- | :--- | :--- | :--- | :--- |
| AD8250ARMZ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 10-Lead Mini Small Outline Package [MSOP] | $\mathrm{RM}-10$ | H 00 |
| AD8250ARMZ-RL | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 10-Lead Mini Small Outline Package $[\mathrm{MSOP}]$ | $\mathrm{RM}-10$ | H 00 |
| AD8250ARMZ-R7 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 10-Lead Mini Small Outline Package $[\mathrm{MSOP}]$ | $\mathrm{RM}-10$ | H 00 |
| AD8250-EVALZ |  | Evaluation Board |  |  |

[^0]$\square$
Data Sheet
NOTES

## NOTES

## X-ON Electronics

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[^0]:    ${ }^{1} Z=$ RoHS Compliant Part.

